

# Photo Report on Test Setups

**Report Reference:** MDE\_PEIKER\_1801\_FCC03/04\_Photo\_Setups

## Test Laboratory:

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### Note:

The following test results relate only to the devices specified in this document. This report shall not be reproduced in parts without the written approval of the test laboratory.

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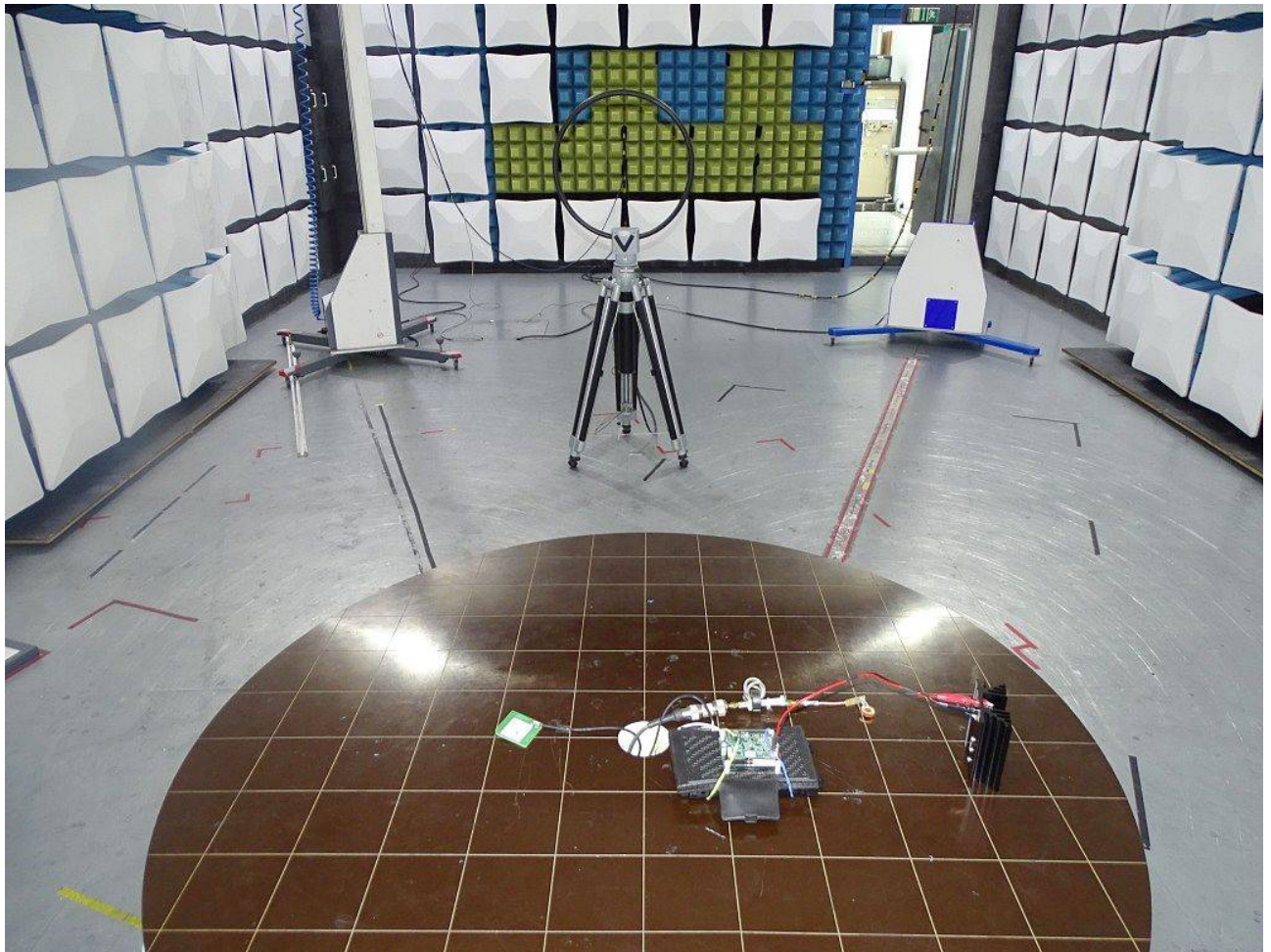
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a Bureau Veritas  
Group Company

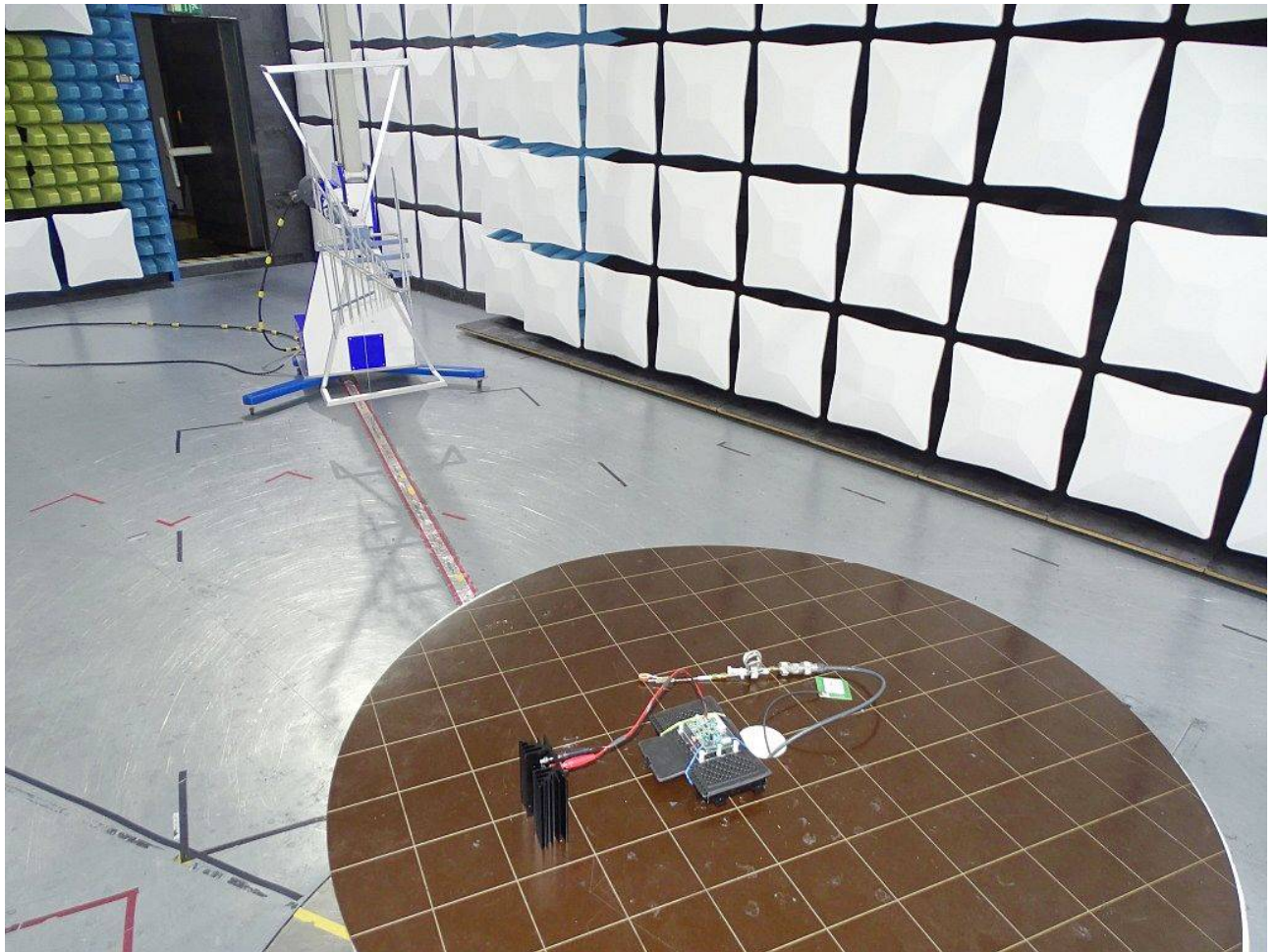
[www.7layers.com](http://www.7layers.com)



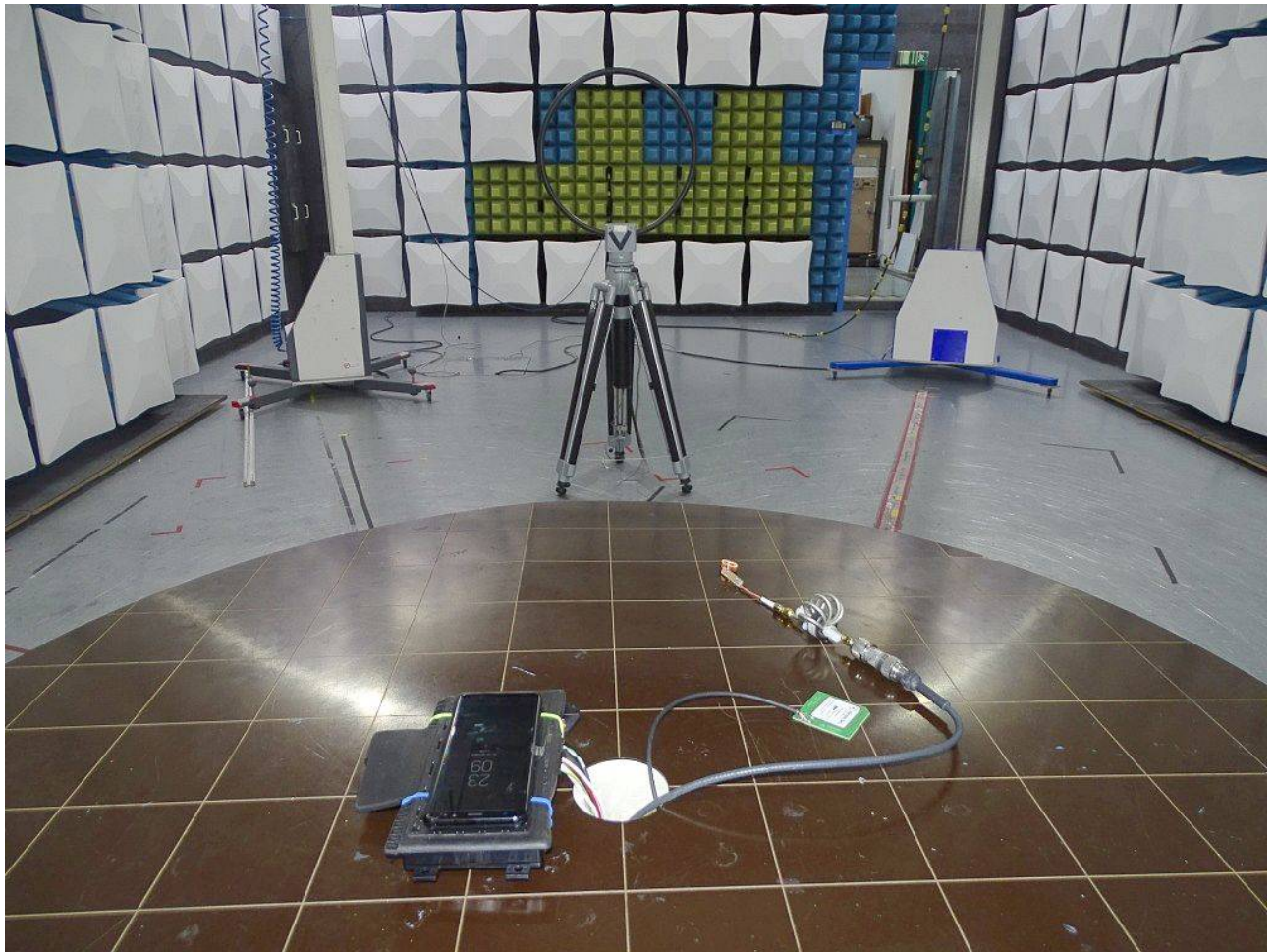
**Photo 1:** Test setup for radiated measurements (Enclosure, semi-anechoic chamber, 9 kHz to 30 MHz, intentional radiator §15, ANSI C63.10)  
EUT horizontal, WPT



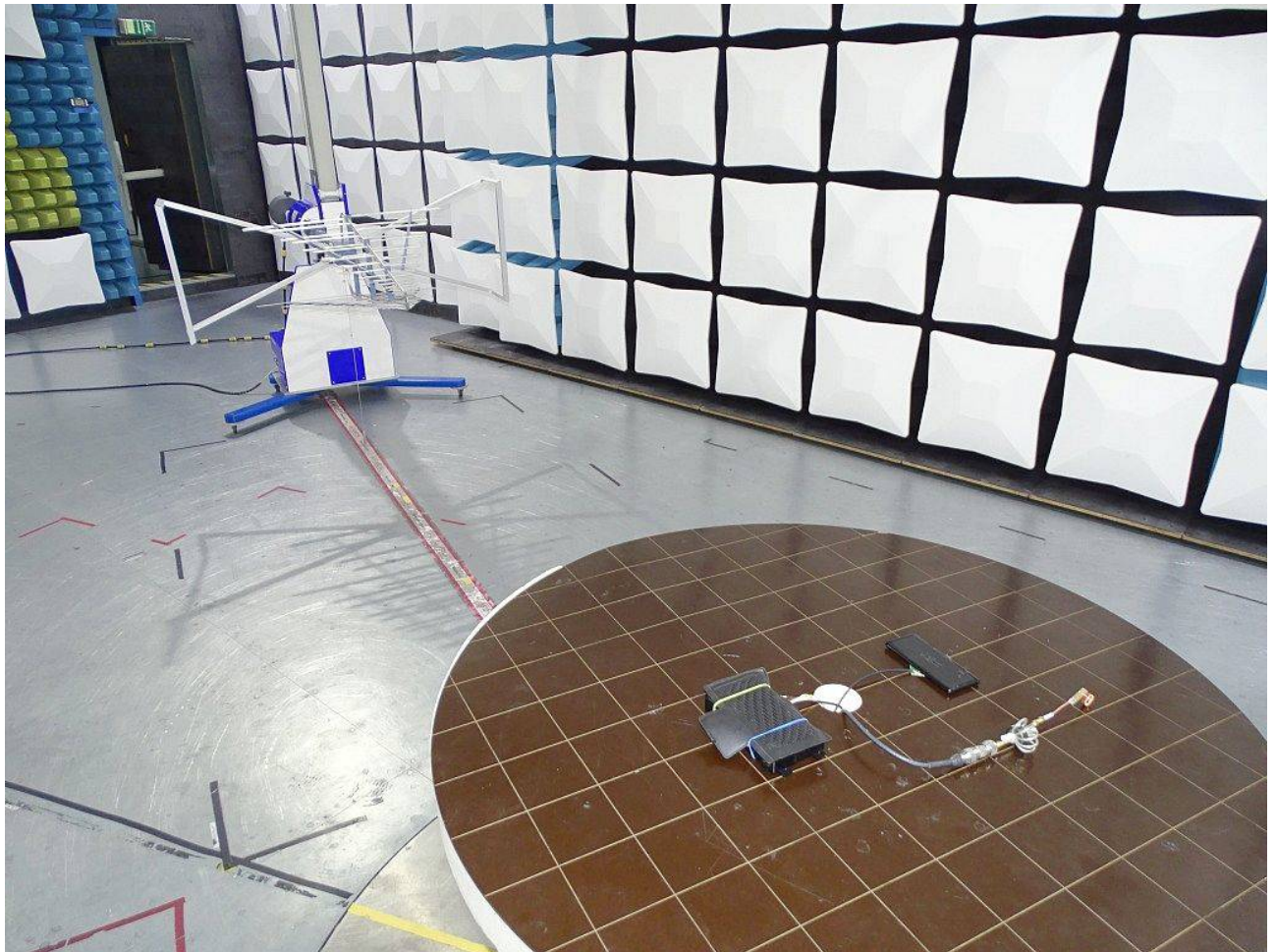
**Photo 2:** Test setup for radiated measurements (Enclosure, semi-anechoic chamber, 9 kHz to 30 MHz, intentional radiator §15, ANSI C63.10)  
EUT vertical, WPT



**Photo 3:** Test setup for radiated measurements (Enclosure, semi-anechoic chamber, 30 MHz to 1 GHz, intentional radiator §15, ANSI C63.10) WPT



**Photo 4:** Test setup for radiated measurements (Enclosure, semi-anechoic chamber, 9 kHz to 30 MHz, intentional radiator §15, ANSI C63.10)  
EUT horizontal,  
NFC, integral antenna



**Photo 5:** Test setup for radiated measurements (Enclosure, semi-anechoic chamber, 30 MHz to 1 GHz, intentional radiator §15, ANSI C63.10) NFC



**Photo 6:** Test setup for radiated measurements (Enclosure, semi-anechoic chamber, NFC integral antenna, detail)



**Photo 7:** Test setup for radiated measurements (Enclosure, semi-anechoic chamber, NFC external antenna, detail)